September 2001

IGBT

FGS15N40L

FAIRCHILD SEMICONDUCTOR®

General Description

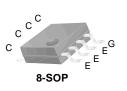
Insulated Gate Bipolar Transistors(IGBTs) with trench gate structure have superior performance in conductance and switching to planar gate structure and also have wide noise immunity. These devices are well suitable for strobe application

Features

- High Input Impedance
- High Peak Current Capability (130A)
- Easy Gate Drive

Application

Strobe Flash





Absolute Maximum Ratings $T_{C} = 25^{\circ}C$ unless otherrwise noted

Symbol	ymbol Description		FGS15N40L	Units	
V _{CES}	Collector-Emitter Voltage		400	V	
V _{GES}	Gate-Emitter Voltage		±6	V	
I _{CM (1)}	Pulsed Collector Current		130	A	
P _C	MaximumPowerDissipation	@ T _a = 25°C	2.0	W	
TJ	Operating Junction Temperature		-40 to +150	°C	
T _{stg}	Storage Temperature Range		-40 to +150	°C	
TL	Maximum Lead Temp. for soldering PurPoses from case for 5 secnds		300	°C	

Notes : (1) Repetitive rating : Pulse width limited by max. junction temperature

Thermal Characteristics

Symbol	Symbol Parameter		Max.	Units
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient(PCB Mount)		62.5	°C/W

Notes: Mounted on 1" square PCB(FR4 or G-10 Material)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Cha	racteristics					
BV _{CES}	Collector-Emitter Breakdown Voltage	$V_{GE} = 0V, I_{C} = 1mA$	450			V
ICES	Collector Cut-off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$			10	μΑ
I _{GES}	G-E leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$			± 0.1	μΑ
On Cha	0			1		
V _{GE(th)}	G-E threshold Voltage	$I_{\rm C} = 0$ V, $I_{\rm C} = 1$ mA	-	-	1.4	V
	G-E threshold Voltage C-E Saturation Voltage	$I_{C} = 0V, I_{C} = 1mA$ $I_{C} = 130A, V_{GE} = 4.0V$	- 2.0	- 4.5	1.4 8.0	V V
V _{GE(th)} V _{CE(sat)}	0		2.0	- 4.5		-
V _{GE(th)} V _{CE(sat)} Dynami C _{ies}	C-E Saturation Voltage	$I_{\rm C} = 130 {\rm \AA}$, $V_{\rm GE} = 4.0 {\rm V}$	- 2.0	- 4.5 3800		-
V _{GE(th)} V _{CE(sat)} Dynami	C-E Saturation Voltage				8.0	V

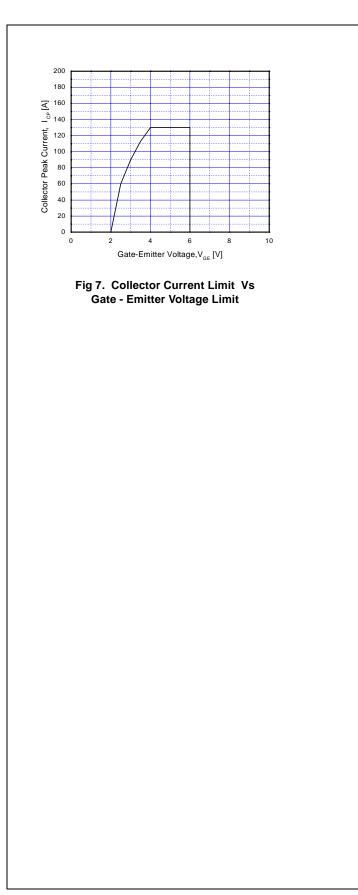
t _{d(on)}	Turn-On Delay Time	V _{CC} = 300V , I _C = 130A	 0.15		us
tr	Rise Time		 1.5		us
t _{d(off)}	Turn-Off Delay Time	V_{GE} = 4.0V , R_G = 15 Ω * Resistive Load	 0.15	0.3	us
t _f	Fall Time		 1.5	3.0	us

Notes : Recommendation of Rg Value : $\text{Rg} \geq 15 \Omega$

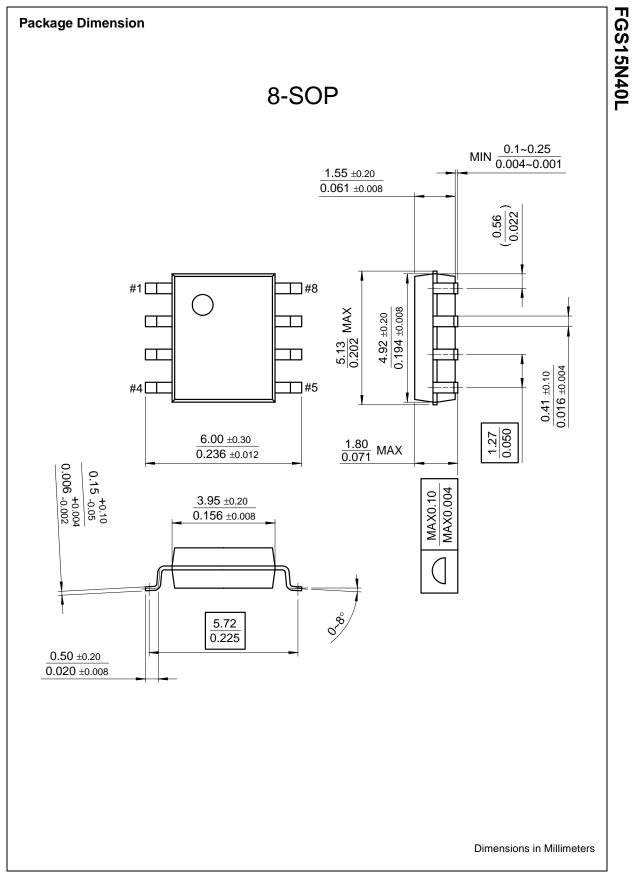
7 Common Emitter $T_c = 25^{\circ}C$ Common Emitte 6١ 5V 180 V_{GE}=4.0V 4V 6 150 Collector-Emitter Voltage, Vce[v] Collector Current, I_{c} [A] Ic=130A 120 5 $V_{GE} = 3V$ 90 lc=100/ 4 60 3 lc=70A 30 0 2 2 4 6 0 8 50 100 -50 0 150 Collector-Emitter Voltage, V_{CE} [V] Case Temperature, $T_{c}[^{\circ}C]$ Fig 1. Typical Output Chacracteristics Fig 2. Saturation Voltage vs. Case Temerature at Variant Current Level 10 Common Emitter 10 ommon Emitte _=-40 ℃ c=25℃ Collector-Emitter Voltage, V_{CE} [V] 8 Collector-Emitter Voltage, V_{CE} [V] 8 6 6 130A 4 4 100A 100A 2 -704 2 =70A 0 0 5 0 1 2 3 4 6 0 1 2 3 4 5 6 Gate-Emitter Voltage ,V $_{\rm GE}\left[\rm V\right]$ Gate-Emitter Voltage ,V_{GE} [V] Fig 3. Saturation Voltage vs. V_{GE} Fig 4. Saturation Voltage vs. V_{GE} 10 10000 Common Emitte T_=150°C Cies Collector-Emitter Voltage, V_{cE} [V] 8 Capacitance [pF] 001 002 Common Emitter V_{GE}=0V f=1MHz T_C=25 °C 6 130A 4 100A Coes =70Å 2 Cres 10 0 0 10 20 30 40 2 3 5 0 1 4 6 Collector-Emitter Voltage, V_{CE} [V] Gate-Emitter Voltage ,V_{GE} [V] Fig 6. Capacitance Characteristics Fig 5. Saturation Voltage vs. V_{GE}

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Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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technical information buy products technical support	back to top Features	-	-
my Fairchild company	 High Input Impedance High Peak Current Capability (130A) Easy Gate Drive 		

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Applications

• Strobe Flash

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Product status/pricing/packaging

Product	Product status	Pricing*	Package type	Leads	Packing method
FGS15N40LTF	Full Production	\$1.36	SOIC	8	TAPE REEL
FGS15N40LTU	Full Production	\$1.36	SOIC	8	RAIL

* 1,000 piece Budgetary Pricing

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